

**FAIRCHILD**  
SEMICONDUCTOR™

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## MM74C150 • MM82C19

### 16-Line to 1-Line Multiplexer 3-STATE • 16-Line to 1-Line Multiplexer

#### General Description

The MM74C150 and MM82C19 multiplex 16 digital lines to 1 output. A 4-bit address code determines the particular 1-of-16 inputs which is routed to the output. The data is inverted from input to output.

A strobe override places the output of MM74C150 in the logical "1" state and the output of MM82C19 in the high-impedance state.

All inputs are protected from damage due to static discharge by diode clamps to  $V_{CC}$  and GND.

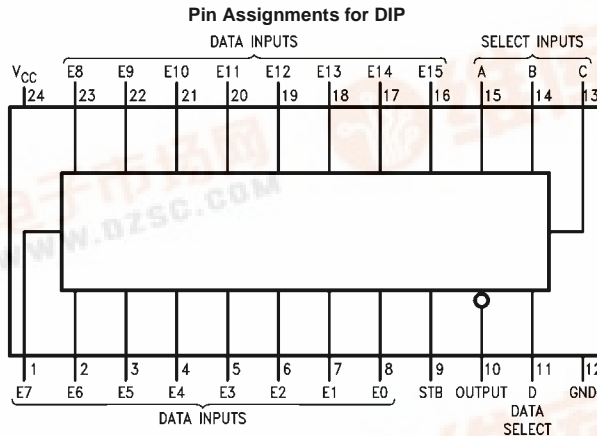
#### Features

- Wide supply voltage range: 3.0V to 15V
- Guaranteed noise margin: 1.0V
- High noise immunity: 0.45  $V_{CC}$  (typ.)
- TTL compatibility: Drive 1 TTL Load

#### Ordering Code:

Order Number	Package Number	Package Description
MM74C150N	N24A	24-Lead plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.600" Wide
MM82C19N	N24A	24-Lead plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.600" Wide

#### Connection Diagram



MM74C150 • MM82C19 16-Line to 1-Line Multiplexer 3-STATE • 16-Line to 1-Line Multiplexer



Truth Table

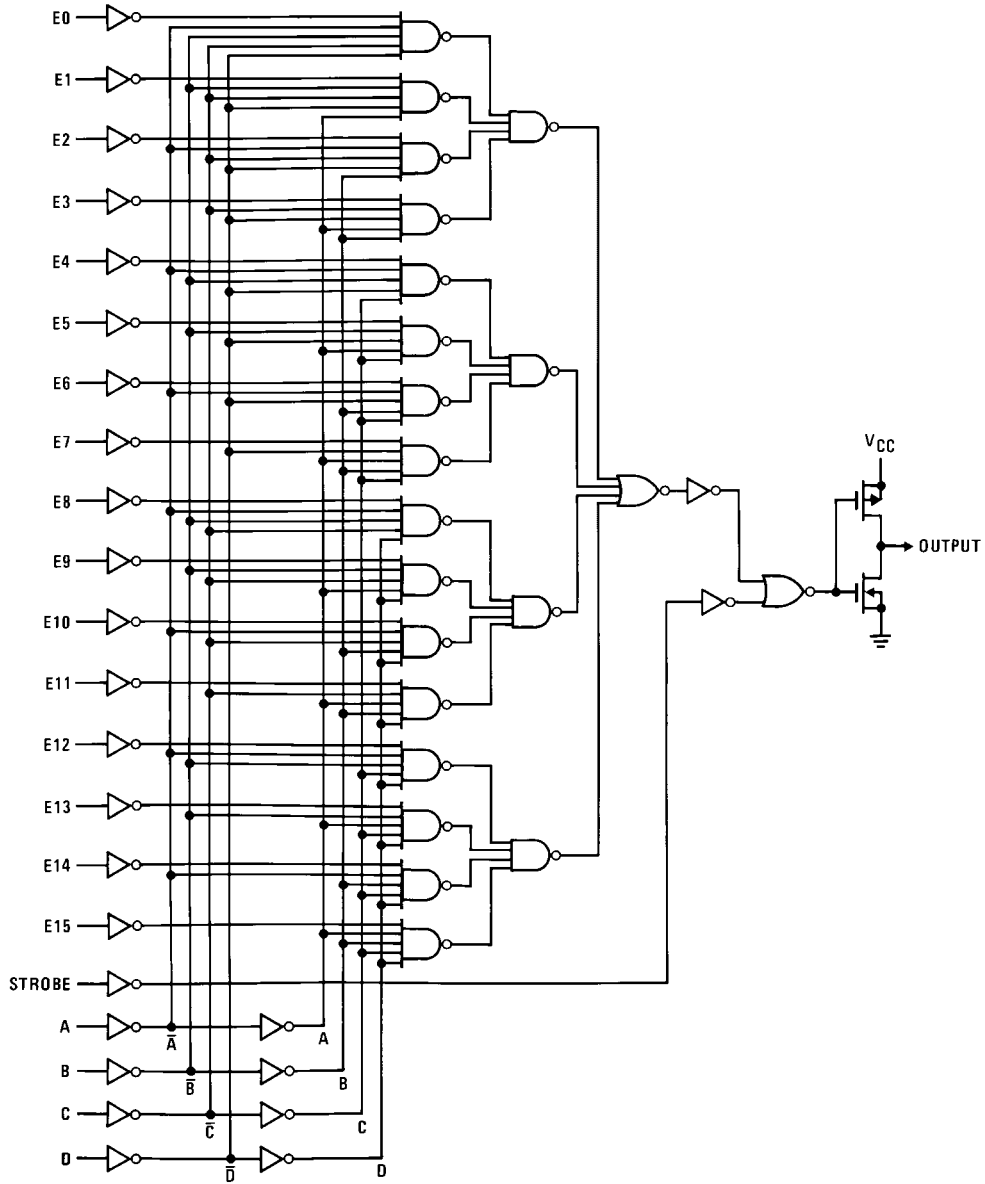
MM74C150

				Inputs															Output			
D	C	B	A	STROBE	E0	E1	E2	E3	E4	E5	E6	E7	E8	E9	E10	E11	E12	E13	E14	E15	W	
X	X	X	X	1	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	1 (Note 1)
0	0	0	0	0	0	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	1
0	0	0	0	0	1	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	0
0	0	0	1	0	X	0	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	1
0	0	0	1	0	X	1	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	0
0	0	1	0	0	X	X	0	X	X	X	X	X	X	X	X	X	X	X	X	X	X	1
0	0	1	0	0	X	X	1	X	X	X	X	X	X	X	X	X	X	X	X	X	X	0
0	0	1	1	0	X	X	X	0	X	X	X	X	X	X	X	X	X	X	X	X	X	1
0	0	1	1	0	X	X	X	1	X	X	X	X	X	X	X	X	X	X	X	X	X	0
0	1	0	0	0	X	X	X	X	0	X	X	X	X	X	X	X	X	X	X	X	X	1
0	1	0	0	0	X	X	X	X	1	X	X	X	X	X	X	X	X	X	X	X	X	0
0	1	0	1	0	X	X	X	X	X	0	X	X	X	X	X	X	X	X	X	X	X	1
0	1	0	1	0	X	X	X	X	X	1	X	X	X	X	X	X	X	X	X	X	X	0
0	1	1	0	0	X	X	X	X	X	X	0	X	X	X	X	X	X	X	X	X	X	1
0	1	1	0	0	X	X	X	X	X	1	X	X	X	X	X	X	X	X	X	X	X	0
0	1	1	1	0	X	X	X	X	X	X	X	0	X	X	X	X	X	X	X	X	X	1
0	1	1	1	0	X	X	X	X	X	X	1	X	X	X	X	X	X	X	X	X	X	0
1	0	0	0	0	X	X	X	X	X	X	X	X	0	X	X	X	X	X	X	X	X	1
1	0	0	0	0	X	X	X	X	X	X	X	X	1	X	X	X	X	X	X	X	X	0
1	0	0	1	0	X	X	X	X	X	X	X	X	X	0	X	X	X	X	X	X	X	1
1	0	0	1	0	X	X	X	X	X	X	X	X	X	1	X	X	X	X	X	X	X	0
1	0	1	0	0	X	X	X	X	X	X	X	X	X	X	0	X	X	X	X	X	X	1
1	0	1	0	0	X	X	X	X	X	X	X	X	X	1	X	X	X	X	X	X	X	0
1	0	1	1	0	X	X	X	X	X	X	X	X	X	X	0	X	X	X	X	X	X	1
1	0	1	1	0	X	X	X	X	X	X	X	X	X	X	1	X	X	X	X	X	X	0
1	1	0	0	0	X	X	X	X	X	X	X	X	X	X	X	0	X	X	X	X	X	1
1	1	0	0	0	X	X	X	X	X	X	X	X	X	X	X	1	X	X	X	X	X	0
1	1	0	1	0	X	X	X	X	X	X	X	X	X	X	X	X	0	X	X	X	X	1
1	1	0	1	0	X	X	X	X	X	X	X	X	X	X	X	X	1	X	X	X	X	0
1	1	1	0	0	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	1	0
1	1	1	0	0	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	1	0
1	1	1	1	0	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	0	1
1	1	1	1	0	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	X	1	0

Note 1: For MM72C19/MM82C19 this would be Hi-Z, everything else is the same.

# Logic Diagrams

MM74C150



MM74C150 • MM82C19



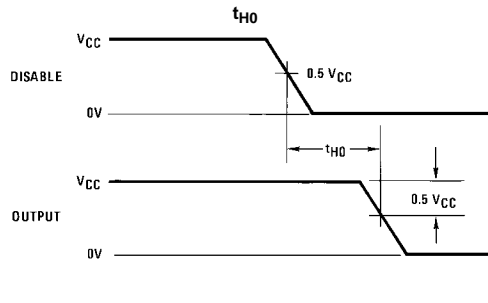
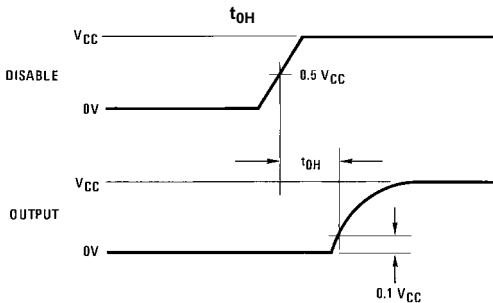
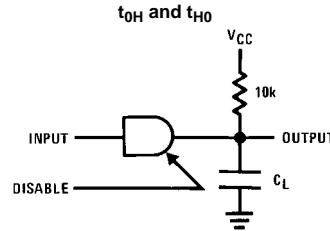
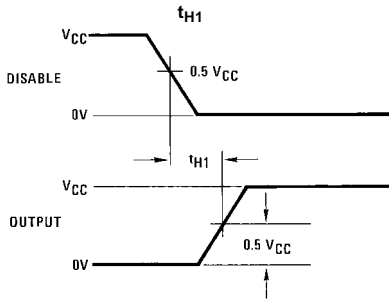
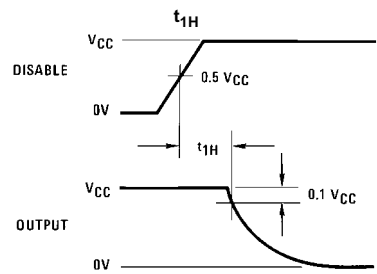
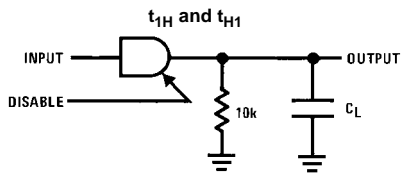
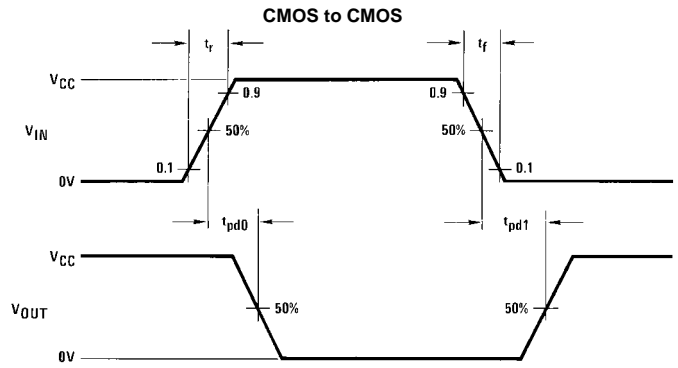
<b>Absolute Maximum Ratings</b> (Note 2)		$V_{CC}$	18V			
Voltage at Any Pin	-0.3V to $V_{CC}+0.3V$	Lead Temperature (soldering, 10 seconds)	260°C			
Operating Temperature Range	-40°C to +85°C					
Storage Temperature Range	-65°C to +150°C					
Power Dissipation						
Dual-In-Line	700 mW					
Small Outline	500 mW					
Operating $V_{CC}$ Range	3.0V to 15V					
<b>Note 2:</b> "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range" they are not meant to imply that the devices should be operated at these limits. The Electrical Characteristic table provides conditions for actual device operation.						
<b>DC Electrical Characteristics</b>						
Min/Max limits apply across temperature range unless otherwise noted.						
Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>CMOS to CMOS</b>						
$V_{IN(1)}$	Logical "1" Input Voltage	$V_{CC} = 5.0V$ $V_{CC} = 10V$	3.5 8.0			V V
$V_{IN(0)}$	Logical "0" Input Voltage	$V_{CC} = 5.0V$ $V_{CC} = 10V$			1.5 2.0	V V
$V_{OUT(1)}$	Logical "1" Output Voltage	$V_{CC} = 5.0V, I_O = -10 \mu A$ $V_{CC} = 10V, I_O = -10 \mu A$	4.5 9.0			V V
$V_{OUT(0)}$	Logical "0" Output Voltage	$V_{CC} = 5.0V, I_O = +10 \mu A$ $V_{CC} = 10V, I_O = +10 \mu A$			0.5 1.0	V V
$I_{IN(1)}$	Logical "1" Input Current	$V_{CC} = 15V, V_{IN} = 15V$		0.005	1.0	V
$I_{IN(0)}$	Logical "0" Input Current	$V_{CC} = 15V, V_{IN} = 0V$	-1.0	-0.005		$\mu A$
$I_{OZ}$	Output Current in High Impedance State MM82C19	$V_{CC} = 15V, V_O = 15V$ $V_{CC} = 15V, V_O = 0V$	-1.0	0.005 -0.005	1.0	$\mu A$ $\mu A$
$I_{CC}$	Supply Current	$V_{CC} = 15V$		0.05	300	$\mu A$
<b>CMOS/LPTTL Interface</b>						
$V_{IN(1)}$	Logical "1" Input Voltage	74C, 82C, $V_{CC} = 4.75V$	$V_{CC}-1.5$			V
$V_{IN(0)}$	Logical "0" Input Voltage	74C, 82C, $V_{CC} = 4.75V$			0.8	V
$V_{OUT(1)}$	Logical "1" Output Voltage	74C, 82C, $V_{CC} = 4.75V, I_O = -1.6 mA$	2.4			V
$V_{OUT(0)}$	Logical "0" Output Voltage	74C, 82C, $V_{CC} = 4.75V, I_O = 1.6 mA$			0.4	V
<b>Output Drive (Short Circuit Current)</b>						
$I_{SOURCE}$	Output Source Current (P-Channel)	$V_{CC} = 5.0V, V_{OUT} = 0V, T_A = 25^\circ C$	-4.35	-8		mA
$I_{SOURCE}$	Output Source Current (P-Channel)	$V_{CC} = 10V, V_{OUT} = 0V, T_A = 25^\circ C$	-20	-40		mA
$I_{SINK}$	Output Sink Current (N-Channel)	$V_{CC} = 5.0V, V_{OUT} = V_{CC}, T_A = 25^\circ C$	4.35	8		mA
$I_{SINK}$	Output Sink Current (N-Channel)	$V_{CC} = 10V, V_{OUT} = V_{CC}, T_A = 25^\circ C$	20	40		mA

**AC Electrical Characteristics** (Note 3) $T_A = 25^\circ\text{C}$ ,  $C_L = 50\text{ pF}$ , unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$t_{pd0}$ , $t_{pd1}$	Propagation Delay Time to a Logical "0" or Logical "1" from Data Inputs to Output	$V_{CC} = 5.0\text{V}$		250	600	ns
		$V_{CC} = 10\text{V}$		110	300	ns
		$V_{CC} = 5.0\text{V}$ , $C_L = 150\text{ pF}$		290	650	ns
		$V_{CC} = 10\text{V}$ , $C_L = 150\text{ pF}$		120	330	ns
$t_{pd0}$ , $t_{pd1}$	Propagation Delay Time to a Logical "0" or Logical "1" from Data Select Inputs to Output	$V_{CC} = 5.0\text{V}$		290	650	ns
		$V_{CC} = 10\text{V}$		120	330	ns
$t_{pd0}$ , $t_{pd1}$	Propagation Delay Time to a Logical "0" or Logical "1" from Strobe to Output MM74C150	$V_{CC} = 5.0\text{V}$		120	300	ns
		$V_{CC} = 10\text{V}$		55	150	ns
$t_{1H}$ , $t_{0H}$	Delay from Strobe to High Impedance State MM82C19	$V_{CC} = 5.0\text{V}$ , $R_L = 10\text{k}$ , $C_L = 5\text{ pF}$		80	200	ns
		$V_{CC} = 10\text{V}$ , $R_L = 10\text{k}$ , $C_L = 5\text{ pF}$		60	150	ns
$t_{H1}$ , $t_{H0}$	Delay from Strobe to Logical "1" Level or to Logical "0" Level (from High Impedance State) MM82C19	$V_{CC} = 5.0\text{V}$ , $R_L = 10\text{k}$ , $C_L = 5\text{ pF}$		80	250	ns
		$V_{CC} = 10\text{V}$ , $R_L = 10\text{k}$ , $C_L = 5\text{ pF}$		30	120	ns
$C_{IN}$	Input Capacitance	Any Input (Note 4)		5.0		pF
$C_{OUT}$	Output Capacitance MM82C19	(Note 4)		11.0		pF
$C_{PD}$	Power Dissipation Capacitance	(Note 5)		100		pF

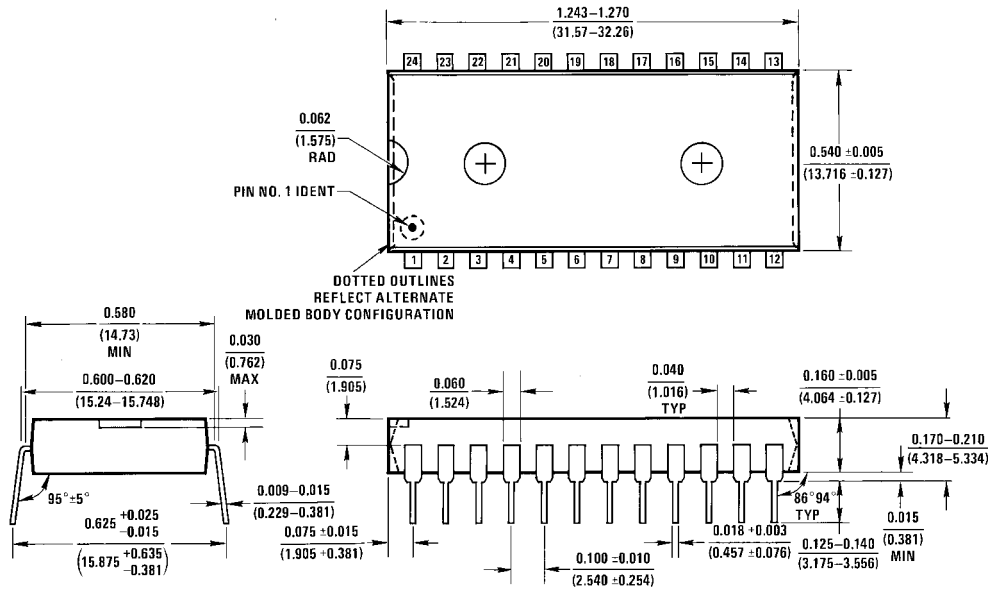
**Note 3:** AC Parameters are guaranteed by DC correlated testing.**Note 4:** Capacitance is guaranteed by periodic testing.**Note 5:**  $C_{PD}$  determines the no load AC power consumption of any CMOS device. For complete explanation, see Family Characteristics, application note AN-90.

### Switching Time Waveforms



**Note:** Delays measured with input  $t_r$ ,  $t_f \leq 20$  ns.

**Physical Dimensions** inches (millimeters) unless otherwise noted



24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.600" Wide  
Package Number N24A

N24A (REV E)

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